

600V N-Channel MOSFET

General Features

- Advanced Planar Process
- > $R_{DS(ON),typ.}=250 \text{ m}\Omega@V_{GS}=10V$
- Low Gate Charge Minimize Switching Loss
- Rugged Poly silicon Gate Structure

Applications

- BLDC Motor Driver
- Electric Welder
- ➢ High Efficiency SMPS

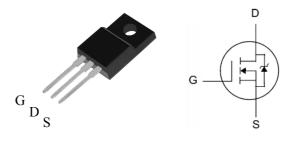
Ordering Information

Part Number	Package	age Brand						
PTA26N60	TO-220F	ï						

Absolute Maximum Ratings

Dead Free Package and Finish

BV _{DSS}	R _{DS(ON),typ.}	I _D
600V	250mΩ	26A



TO-220F Package

 $T_C \text{=} 25\,^\circ\!\!\mathbb{C}$ unless otherwise specified

Symbol	Parameter	PTA26N60	Unit
V _{DSS}	Drain-to-Source Voltage	600	V
V _{GSS}	Gate-to-Source Voltage	±30	V
	Continuous Drain Current	26	
ID	Continuous Drain Current @ Tc=100°C	17	А
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2,4]	104	
E _{AS}	Single Pulse Avalanche Energy	1500	mJ
dv/dt	Peak Diode Recovery dv/dt ^[3]	5.0	V/ns
Р	Power Dissipation	88	W
P _D	Derating Factor above 25°C	0.70	W/°C
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	Ĉ
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTA26N60	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	1.42	
R _{θJA}	Thermal Resistance, Junction-to-Ambient	100	°C M

Electrical Characteristics

OFF Characteristics T_J =25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	600			V	V_{GS} =0V, I _D =250uA
	- Drain-to-Source Leakage Current			1	uA	V _{DS} =600V, V _{GS} =0V
I _{DSS}		-		125		V _{DS} =480V, V _{GS} =0V, T _J =125℃
1	Cate to Source Leakage Current			+100	- nA	V_{GS} =+30V, V_{DS} =0V
I _{GSS}	Gate-to-Source Leakage Current			-100	ПА	V _{GS} =-30V, V _{DS} =0V

ON Characteristics

ON Characteristics				T_J =25 $^\circ\!\mathrm{C}$ unless otherwise specified		
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		250	350	mΩ	V _{GS} =10V, I _D =13A
$V_{GS(TH)}$	Gate Threshold Voltage	2.0		4.0	V	V_{DS} = V_{GS} , I_D =250uA
gfs	Forward Transconductance		32		S	Vds =25V, Id=13A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		4.28		nF	V _{GS} =0V, V _{DS} =25V, f=1.0MH _Z
C _{rss}	Reverse Transfer Capacitance		0.19			
C _{oss}	Output Capacitance		1.41			
Qg	Total Gate Charge		78			
Q _{gs}	Gate-to-Source Charge		21		nC	V_{DD} =300V, I _D =26A, V_{GS} =0 to 10V
Q _{gd}	Gate-to-Drain (Miller) Charge		20			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		25			
trise	Rise Time		39			V _{DD} =300V, I _D =13A,
td(OFF)	Turn-Off Delay Time		100		nS	V _{GS} = 10V Rg=10Ω
tfall	Fall Time		36		-	

Source-Drain Body Diode Characteristics

 $T_J {=} 25\,^\circ\!\! {\rm C}$ unless otherwise specified

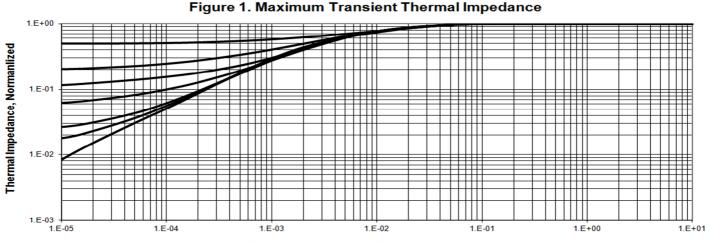
Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions	
I _{SD}	Continuous Source Current ^[2]			26	A	Integral PN-diode in MOSFET	
I _{SM}	Pulsed Source Current ^[2]			104			
V _{SD}	Diode Forward Voltage			1.5	V	I _S =28A, V _{GS} =0V	
trr	Reverse recovery time		535		ns	V _{GS} =0V ,IF=28A,	
Qrr	Reverse recovery charge		4.6		uC	di⊧/dt=100A/µs	

Note:

[1] $T_{\rm J}\text{=+}25\,^\circ\!\!\mathbb{C}$ to +150 $^\circ\!\!\mathbb{C}$.

- [2] Silicon limited current only.
- [2] Sincon infinited current only.
 [3] Package limited current.
 [4] Repetitive rating; pulse width limited by maximum junction temperature.
 [5] Pulse width≤380µs; duty cycle≤2%.

Typical Characteristics



Rectangular Pulse Duration, Seconds

30

28

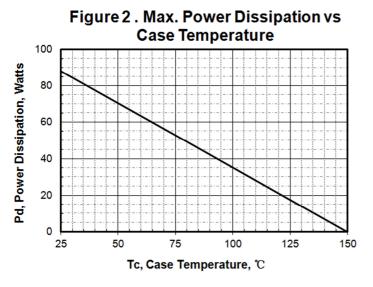


Figure 4. Output Characteristics

Vgs=10V

Vgs=9V

Vgs=6V

Vgs=5V

8

Vgs=7V

32

28

24 20

16

12

8.0

4.0

0

0

2

4

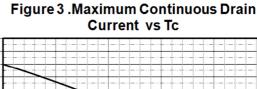
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TC = 25 ℃

ld, Drain Current, Amps

PULSE DURATION = 100 µS

DUTY FACTOR = 0.5% MAX



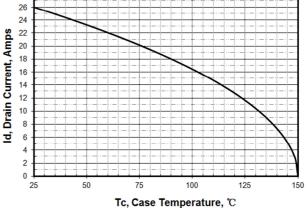
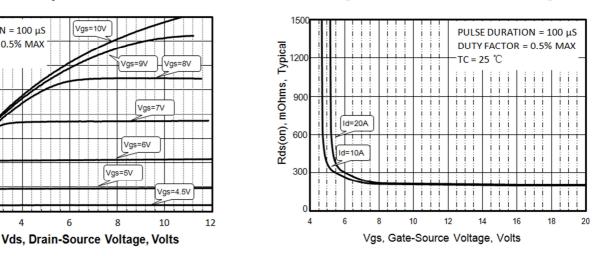


Figure 5. Rdson vs Gate Voltage

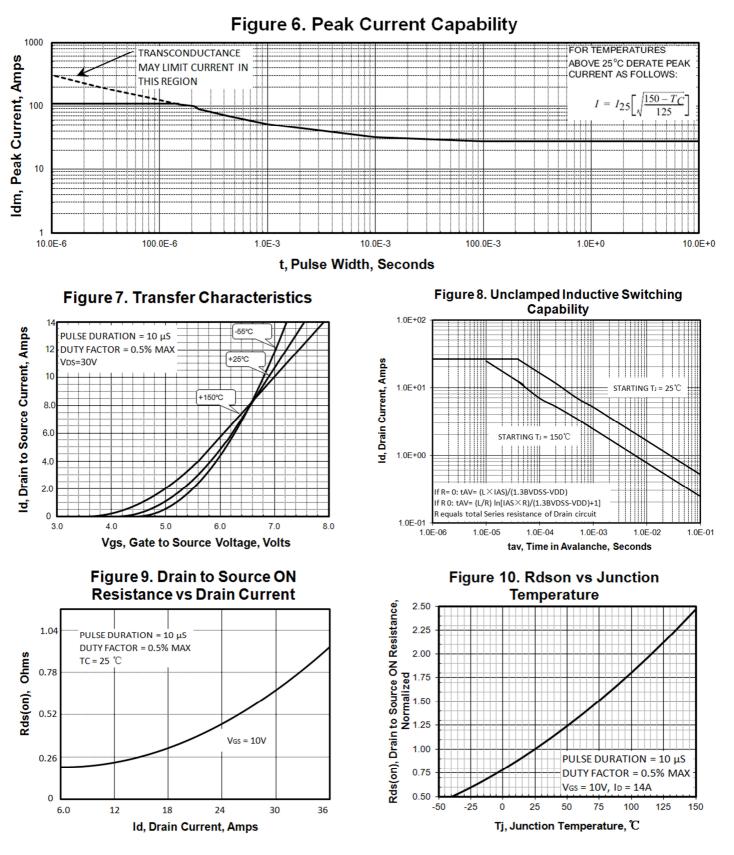


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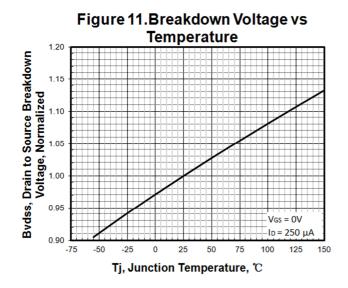
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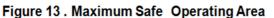


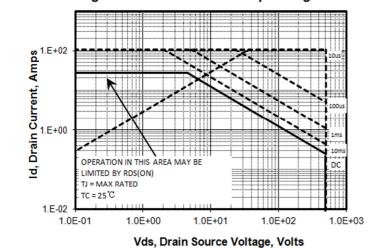
Typical Characteristics(Cont.)



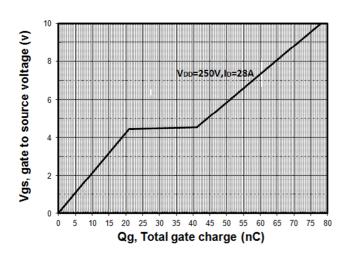
Typical Characteristics(Cont.)

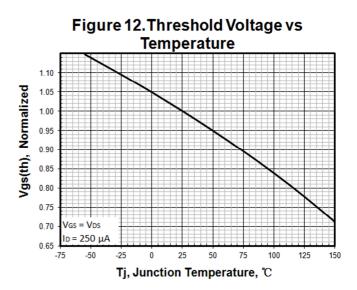


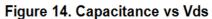












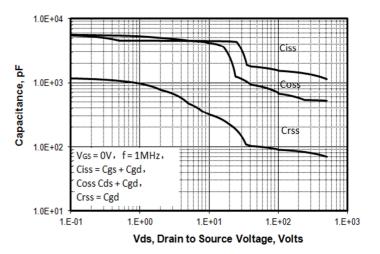
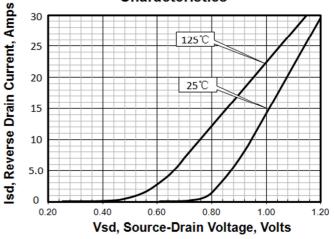
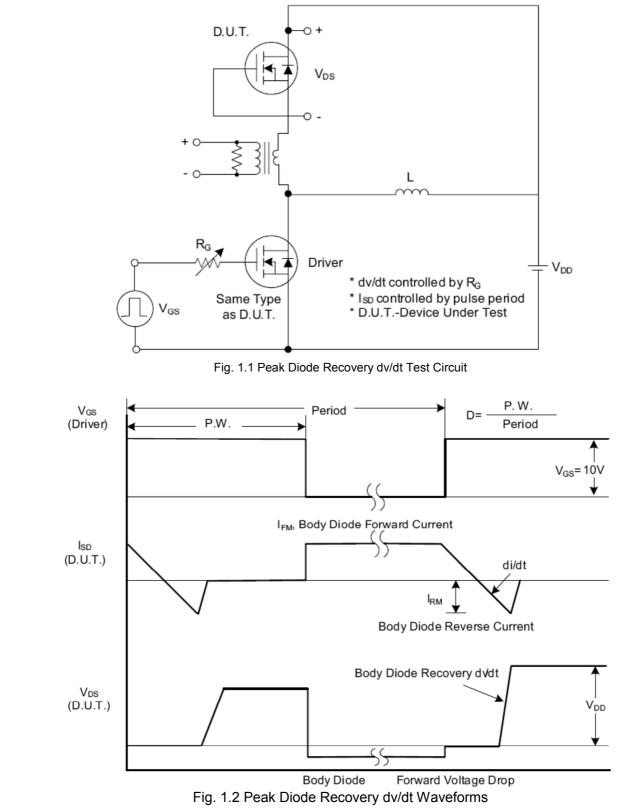


Figure 16.Body Diode Transfer Characteristics



Test Circuits and Waveforms



PTA26N60

Test Circuits and Waveforms (Cont.)

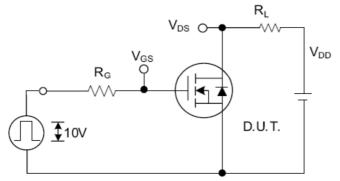


Fig. 2.1 Switching Test Circuit

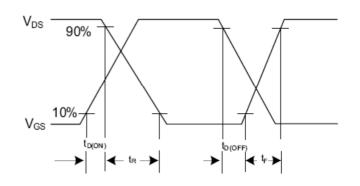


Fig. 2.2 Switching Waveforms

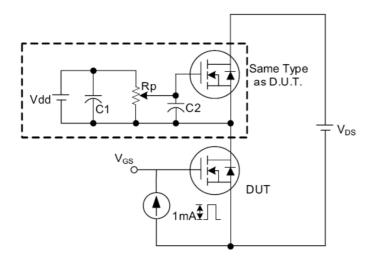


Fig. 3 . 1 Gate Charge Test Circuit

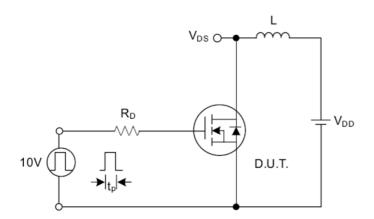
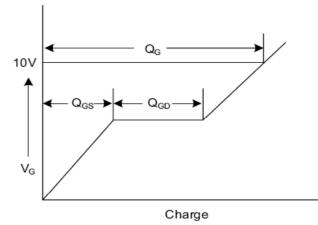
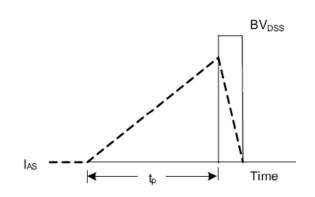
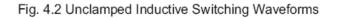


Fig. 4.1 Unclamped Inductive Switching Test Circuit









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